

FORM PTO-1449

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

Sheet 1 of 1

ATTORNEY DOCKET NO. APPLICATION NO.

1720.1003 10/620,597

INFORMATION DISCLOSURE STATEMENT

(Use several sheets if necessary)

Seiji HACHISUKA et al.
FILING DATE GROUP ART UNIT
July 17, 2003 2858

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
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FOREIGN PATENT DOCUMENTS

. •			DOCUMENT NO.	DATE	COUNTRY	TRANSLATION YES NO	ABSTRACT
7	AD.	AG	11-252937	9/1999	Japan		Х
		AH	03-207274	9/1991	Japan		X
		Al	09-182449	7/1997	Japan	·	Χ .
	,	AJ	54-82624	7/1979	Japan	Partial	
		AK	2002-341775	11/2002	Japan	Partial	X
		AL					

OTHER RE	FEREN	CES (Including Author, Title, Date, Pertinent Pages, Etc.)	TRANSL YES	ATION NO
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EXAMINER	/Anjan Deb/ (01/26/2007)	DATE CONSIDERED
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



ATTACHMENT 1(g)

LIST OF ADDITIONAL SUBMITTED DOCUMENTS

ATTORNEY DOCKET NO.	APPLICATION NO.
1720.1003	10/620,597
FIRST NAMED INVENTOR	
Seiji HACHISUKA et a	l
FILING DATE	GROUP ART UNIT
July 17, 2003	2858

The following document(s) is/are listed in accordance with the duty of disclosure provisions of 37 CFR § 1.56, so that the Examiner may consider same should he deem any thereof to be material to examination of the subject application.

It is requested that the Examiner acknowledge his consideration of document(s) below-listed by initialling same in the space provided adjacent each such application and that the Examiner sign and date this form at the bottom thereof to confirm such consideration having been given.

This submission in no way represents an admission that any of the information listed herein constitutes prior art with respect to the subject application; and unless and until such prior art status is established, this submission is not a request that the information presented herein be printed on the face of any patent issuing from the subject application in which this information is being filed.

U.S. PATENT DOCUMENTS

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FOREIGN PATENT DOCUMENTS

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OTHER D	OCUME	ENTS (Including Author, Title, Date, Pertinent Pages, Etc.)	TRANSI YES	ATION NO
AD	AE	Notification of Reasons for Refusal from Japanese Patent Office dated		X

EXAMINER	/Anjan Deb/ (11/18/2006)	DATE CONSIDERED
*EXAMINER: In citation if not in co	nitial if document considered, whether or on onformance and not considered. Include	not citation is in conformance with MPEP 609; Draw line through copy of this form with next communication to applicant.



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FORM PTO-1449	U.S. DEPARTMENT OF COMMERCE	ATTORNEY DOCKET NO.	APPLICATION NO.
	PATENT AND TRADEMARK OFFICE	1720.1003	10/620,597
_		FIRST NAMED INVENTOR	
INFORMATION	I DISCLOSURE STATEMENT	Seiji HACHISUKA et	t al.
		FILING DATE	GROUP ART UNIT
(Use se	everal sheets if necessary)	July 17, 2003	2858

U.S. PATENT DOCUMENTS

			U.S. PA	IENT DOCUMENTS			
*EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
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FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	TRANSLA YES	TION NO	ABSTRACT
AD	AG	1351408	5/2002	China		Х	
W	AH	11/122819	4/1999	Japan			X
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	AK						
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)					
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EXAMINER /Anjan Deb/ (11/18/2	DATE CONSIDERED	

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1720.1003	10/620,597
FIRST NAMED INVENTOR	
Seiji HACHISUKA et al	
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U.S. PATENT DOCUMENTS

	*EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
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FOREIGN PATENT DOCUMENTS

	DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSL YES	NO NO
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AD							

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)					
AD	AE	Office Action for corresponding Chinese Application No. 03150194X dated June 17, 2005.		Χ.	

EXAMINER	/Anjan Deb/	(11/18/2006)	DATE CONSIDERED
			itation is in conformance with MPEP 609; Draw line through of this form with next communication to applicant.



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ATTORNEY DOCKET NO.	APPLICATION NO.
1720.1003	10/620,597
FIRST NAMED INVENTOR	
Seiji HACHISUKA et al.	_
FILING DATE	GROUP ART UNIT
July 17, 2003	2858

The following document(s) is/are listed in accordance with the duty of disclosure provisions of 37 CFR § 1.56, so that the Examiner may consider same should he deem any thereof to be material to examination of the subject application. Pursuant to 37 CFR 1.98(a)(2)(iii), a copy of any identified copending application(s) is provided.

It is requested that the Examiner acknowledge his consideration of document(s) below-listed by initialling same in the space provided adjacent each such application and that the Examiner sign and date this form at the bottom thereof to confirm such consideration having been given.

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U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
AD	AA	2004-0012987 A1	1/2004	Hachisuka et al.			
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FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSL YES	ATION NO
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	AD							

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)	TRANSL YES	ATION NO
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ATTACHMENT 1(f)

LIST OF COPENDING APPLICATIONS

ATTORNEY DOCKET NO.	APPLICATION NO.
1720.1003	Unassigned
FIRST NAMED INVENTOR	•
Seiji HACHISUKA	
FILING DATE	GROUP ART UNIT
July 17, 2003	Unassigned

The following, prior-filed, copending U.S. patent application(s) is/are listed in accordance with the duty of disclosure provisions of 37 CFR § 1.56, so that the Examiner may consider same should he deem any thereof to be material to examination of the subject application. Pursuant to 37 CFR 1.98(a)(2)(iii), a copy of the identified copending application(s) is provided.

It is requested that the Examiner acknowledge his consideration of application(s) below-listed by initialling same in the space provided adjacent each such application and that the Examiner sign and date this form at the bottom thereof to confirm such consideration having been given.

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U.S. PATENT APPLICATION DOCUMENTS

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	U.S. SERIAL NO.	FILING DATE	NAME	ASSIGNEE					
1	10/368,598	2/20/03	Seiji HACHISUKA, et al.	FUJITSU LIMITED					
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	2 3 4 5 6	U.S. SERIAL NO. 1 10/368,598 2 3 4 5 6 7	U.S. SERIAL NO. FILING DATE 1 10/368,598 2/20/03 2 3 4 5 6 7	U.S. SERIAL NO. FILING DATE NAME 1 10/368,598 2/20/03 Seiji HACHISUKA, et al. 2 3 4 5 6 7					

EXAMINER	/Anjan Deb/	(01/26/2007)	DATE CONSIDERED
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FORM PTO-1449

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

LIST OF REFERENCES CITED BY APPLICANT

(Use several sheets if necessary)

ATTORNEY DOCKET NO.	APPLICATION NO.	
1720.1003	Unassigned	
FIRST NAMED INVENTOR		
Seiji HACHISUKA		
FILING DATE	GROUP ART UNIT	
July 17, 2003	Unassigned	

U.S. PATENT DOCUMENTS

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EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
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FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSLATION YES NO
AD	AG	11-354285	12/24/99	Japan			Abstract
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	AJ						
	AK	:					
	AL						

OTHER REFERENCES (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)

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EXAMINER	/Anjan Deb/	(11/18/2006)	DATE CONSIDERED
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PATENT AND TRADEMARK OFFICE	1720.1003	10/620,597
	FIRST NAMED INVENTOR	<u> </u>
LIST OF REFERENCES CITED BY APPLICANT	Seiji HACHISUKA et al.	
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U.S. PATENT DOCUMENTS

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*EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
AD	AA	6,111,732	8/29/00	Beland			
	AB	5,892,646	4/6/99	Parker et al.			
	AC	5,952,791	9/14/99	Suzuki et al.			
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FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSL YES	ATION NO
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OTHER RE	FERE	NCES (Including Author, Title, Date, Pertinent Pages, Etc.)	TRANSI YES	ATION NO
AD	AJ	Patent Abstracts of Japan vol. 1999, no. 09, 30 July 1999 & JP 11 121190 (Hitachi Ltd), 30 April 1999		
	AK	Patent Abstracts of Japan vol. 018, no. 442 (E-1593), 17 August 1994 & JP 06 140173 (Nippondenso Co Ltd) 20 May 1994		
	AL	Ondo K et al: "Thin type DC/DC converter using a coreless wire transformer" Power Electronics Specialists Conference, PESC '94 Record., 25 th Annual IEEE Taipei, Taiwan 20-25 June 1994, New York, NY USA, IEEE, 20 June 1994, pp. 1330-1334, XP010121291		
V	AM	Turner G R et al: "Rogowski coils for short duration (>10 / spl mu/S) pulsed current (<10 kA) measurements" Africon, 1999 IEEE Cape Town, South Africa 28 Sept. –1 Oct. 1999, Piscataway, NJ, USA, IEEE, US, 28 September 1999, pp. 759-764, XP010367259		

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